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1. Field of the Invention

The present invention relates to electrical phase measurements and particularly to a signal processing apparatus for providing accurate electrical phase difference measurement of multiple signal inputs concurrently.

2. Description of the Related Art

Electrical phase detection and/or measurement is a prerequisite requirement for numerous signal processing, communication, and signal measurement systems in use today and in the foreseeable future. Many such systems require and utilize multiple parallel input channels for concurrent transduction and conversion of received signals for the purpose of extracting relative phase parameters as a function of time for each input channel. Two current day examples are satellite (and terrestrial) communications systems utilizing multiple phase modulated radio frequency(RF) channels and, single or multiple channel RF interferometers for accurate positional or angular bearing measurement in geolocation or general radio direction finding applications.

Present approaches include multiple individual phase
measurement devices (operated in parallel), for which the
measured phase accuracy of such devices is generally more
sensitive to input signal strength variations. For example, most
RF phase detectors in use today are designed to operate within a
limited input signal dynamic range, typically in the detector
saturation region, and as such are essentially confined to single
signal operation at a given instant of time. Multiple time and
frequency coincident input signals tend to mutually interfere
such that the composite resultant phase detector output is
distorted or incorrect.

Current optical phase interferometers such as the Mach-
Zehnder configuration provide precise distance or phase
difference measurement either by counting interference fringes or
by interference pattern intensity variation measurements using a
single photodetector element. Phase differences are injected to
modulate one of the two optical paths typically by a change of
path length or by optical phase modulation device. Optical
intensity at the photodetecting element must be calibrated (or
referenced) to one or more known input phase conditions to
determine the signal modulation index amplitude and initial phase
offset, and image plane optical intensity offset measured
separately to correctly extract phase differences. Additionally,
the range of operational signal levels are constrained by the use
of signal strength as the only measurement variable. The
additional requirement to measure optical modulation index, intensity offset, and the time sequential nature of the measurement further complicates use of optical interferometers for phase measurement, especially in the case where incident signal strength is a uncontrolled dynamic variable.

Typical coherent signal processing requires relatively complex and expensive processing hardware per channel to operate at intermediate frequencies (IF). A typical coherent approach requires a carrier mixing and filtering operation to convert to an corresponding IF signal which must then be time-domain processed to measure phase.

Summary of the Invention

It is therefore an object of the invention to provide a signal processing apparatus which performs phase measurement by spatial sampling.

Another object of the invention is to provide a signal processing apparatus for providing accurate electrical phase difference measurement of multiple signal inputs concurrently.

Another object of the invention is to provide a signal processing apparatus which can provide phase measurement of an individual signal input by utilizing an efficient three-point spatial sampling technique.
A further object of this invention is to measure relative electrical phase of multiple input radio frequency signals concurrently, wherein signals are assumed independent of each other in both phase and electrical amplitude and differ in frequency.

These and other objects of this invention are achieved by providing a signal processing apparatus for providing accurate electrical phase difference measurement of multiple signal inputs concurrently. In operation, measurement and reference wideband RF inputs, differing primarily in phase over frequency, are respectively applied to two RF Channelizer components. Each Channelizer separates the composite input bandwidth into multiple time-coincident frequency output channels. Corresponding pairs of output channels then phase modulate a common independent carrier which propagates to the detection plane of a photodetector array forming a spatial interference pattern along one axis for each frequency channel number. A preferred detector element scaling relative to the interference pattern affords efficient phase difference measurement incorporating three intensity-sensing detector elements at each frequency channel. Conversion of the resulting amplitudes from the preferred three detector elements to relative signal phase is accomplished with an algorithm. Phase measurement of an individual signal input is accomplished utilizing an efficient spatial sampling scheme.
Brief Description of the Drawings

These and other objects, features and advantages of the invention, as well as the invention itself, will become better understood by reference to the following detailed description when considered in connection with the accompanying drawings wherein like reference numerals designate identical or corresponding parts throughout the several views and wherein:

Fig. 1 illustrates a generalized schematic block diagram of the multiple parallel phase measurement apparatus of the invention;

Fig. 2 illustrates a schematic block diagram of a preferred embodiment of the multiple parallel phase measurement apparatus of the invention;

Fig. 3 shows a local view of the two beam spatial interference intensity pattern and its size relative to the detector element size and separation pitch;

Fig. 4 shows a global view of the two beam spatial interference intensity pattern enclosed within a beam profile envelope typically found in practice;

Fig. 5 illustrates a schematic block diagram of the multiple parallel phase measurement apparatus of the invention in a passive direction finding receiver application; and

Fig. 6 shows phase measurement performance of the exemplary apparatus of Fig. 2 to a single input RF signal applied.
Detailed Description of the Preferred Embodiments

Referring now to the drawings, Fig. 1 illustrates a generalized schematic block diagram of the multiple parallel phase measurement apparatus of the invention for providing accurate electrical phase difference measurement of multiple signal inputs concurrently.

For purposes of this discussion of the specification, a common carrier wavefront will be assumed to be a common optical carrier and input signals will be assumed to be single or composite radio frequency (RF) input signals received at different locations of the apparatus by, for example, two dipole antennas on a phased array antenna. However, it should be realized that the input signals may be sound, heat, light, electrical voltage, or any measureable quantity which may be modulated onto a common carrier at multiple differing frequency offsets. Although an optical carrier (acousto-optic channelization) was used in the preferred embodiment of Fig. 2 (to be discussed), the common carrier may also be represented in other forms (i.e. radio waves) or frequency spectral ranges as well. Thus, for example, RF applications may utilize microwave or millimeter bands, or optical applications operating at infrared or ultraviolet wavelengths.

In the operation of the apparatus of Fig. 1, a common
carrier wavefront is projected through a split aperture comprised of two columns 11 and 13 of phase modulator apertures, which together form a 2 x N array of phase modulator apertures 15.

A channelizer or RF channelizer circuit 17 is responsive to an input reference (REF) composite RF signal (which contains within a composite RF bandwidth individual RF signals independent of each other in frequency, phase and electrical amplitude) for separating the input composite RF bandwidth into multiple time-concurrent frequency output channels. In other words, the reference composite signal includes a composite of reference phase signals at each frequency within the composite RF bandwidth.

At the same time a channelizer or RF channelizer circuit 19 is responsive to an input measurand (MEAS) composite RF signal (which contains within the composite RF bandwidth individual RF signals independent of each other in frequency, phase and electrical amplitude) for separating the input composite input RF bandwidth into multiple time-concurrent frequency output channels. (The term "measurand" means "that which is to be measured".) In other words, the measurand composite signal includes a composite of phase signals for which relative phase is to be measured at each frequency within the composite RF bandwidth. Thus, each of the channelizers 17 and 19 frequency-segment or sort-select the various frequencies within the
composite RF bandwidth into fixed channel widths or bins in
frequency which are numbered 1 through N.

It should be noted at this time that both of the reference
and measurand composite signals contain the same wideband
frequency range inputs, and that each signal frequency in the
reference composite signal applied to the channelizer 17 is also
concurrently provided in the measureand composite signal that is
applied to the channelizer 19. However, there is a phase
difference between corresponding frequency components applied to
the channelizers 17 and 19.

Corresponding frequency output channels of each of the
channelizers 17 and 19 then phase modulate (and optionally
amplitude modulate) the common independent carrier signal and
exit through the 2 x N array of phase modulator apertures 15.

Upon exit from each pair of apertures corresponding to a
particular frequency channel in the phase modulator apertures 15,
the modulated carriers propagate and combine spatially, resulting
in a two-beam spatial phase interference pattern, as measured by
intensity, projecting onto a corresponding row of a detector
array 21.

One axis (indicated in Fig. 1 as the Y-axis) of the detector
array 21 corresponds to frequency channel number, while the
orthogonal axis (indicated in Fig. 1 as the X-axis) corresponds
to relative signal phase (and amplitude) information in spatial
form as a sinusoidal intensity pattern. The number of detection
elements is chosen as three (in the minimal case), with a
preferred element separation or pitch corresponding to
substantially ninety degrees phase. The number of implemented
detector elements is chosen to reduce the total quantity of
sampling elements, allow for required intensity offset
correction, and to maximize signal energy utilization. A detector
element sensing region width narrower than the element spacing
will also provide the desired phase extraction function with
proportionally lower energy utilization as long as the spacing
period or pitch is maintained. Spatial intensity modulation
along the phase axis X of the detector array 21 affords
simultaneous recovery of relative signal phase and removal of the
intensity offset during a single sample time.

Conversion of the preferred three detector element intensity
values to relative phase is straightforward and efficient since
both in-phase and quadrature information is captured
simultaneously. Although not shown in Fig. 1, the intensity
values of each group of three detectors shown in Fig. 1 may be
converted to a relative phase difference ($\Delta\phi$) by, for example, a
phase extraction processor shown in Figs. 2 and 2A (to be
explained.

Fig. 2 illustrates a schematic block diagram of a preferred
embodiment of the multiple parallel phase measurement apparatus
of the invention. The embodiment of Fig. 2 can be called a
channelized phase detector (CPD).

In the preferred embodiment of Fig. 2, a monochromatic
optical source, such as a laser 23, emits a coherent laser beam
or common carrier wavefront. This coherent laser beam is split
by a beam splitter 25 into two optical or light beams which
illuminate a dual channel acousto-optic Bragg cell comprised of
Bragg cells 27 and 29. RF inputs RF \(_0\) and RF \(_1\) from, for example,
a selected antenna pair (not shown) of, for example, a phased
array antenna (not shown) are respectively applied to the two
Bragg cells 27 and 29. One antenna of the selected antenna pair
represents a common reference antenna and the other antenna of
the selected antenna pair represents a measurand antenna for
which channelized phase difference is to be measured.

Within the respective Bragg cells 27 and 29, each associated
illuminating light beam is modulated by the frequency and phase
of its associated RF input. For a given input angle of arrival \(\theta_a\)
associated with an RF signal source, the relative phase
difference across the associated antenna element pair is applied
to the RF \(_0\) and RF \(_1\) inputs to the Bragg cells 27 and 29 and is
replicated (or modulated) in optical outputs of the Bragg cells
27 and 29. Upon exiting the Bragg cells 27 and 29, the two
optical beams therefrom interfere spatially to develop an
interference pattern along a phase or X-axis, and are deflected
along the orthogonal axis at an angle approximately proportional
to the incident RF signal frequency. This optical interference
pattern is Fourier-transformed by a Fourier Transform lens 31 and
imaged onto an area detector or photodetector array 33.

Thus, the resulting photodetector image intensity
modulation pattern is two-dimensional, with phase interference
occurring along the X-axis and the RF signal Fourier transform
occurring along the Y-dimension or Y-axis, as depicted in
Figure 2.

Three detector elements span the X-axis or phase axis in the
photodetector array 33 to sense intensity with preferred interval
spacing of ninety degrees each. This configuration serves to
minimize the required number of sampling elements, provide for
optical intensity offset correction, and to maximize signal
energy utilization. Detector element sensing regions narrower
than the spacing pitch of ninety degrees will also provide the
desired phase extraction function (with lower energy efficiency
however) as long as the spacing pitch is maintained at ninety
degrees.

In each of the Bragg cells or elements 27 and 29 of Fig 2,
Bragg diffraction of the of the RF modulated optical beams
results in deflection of individual frequency components along
the frequency channelization axis or Y-axis by an angle
approximated by Equation 1.
\[ \theta = \lambda \cdot f_s / 2nV_s \]  

where:
\[ \lambda \] = optical wavelength,  
\[ f_s \] = acoustic (RF) frequency,  
\[ V_s \] = acoustic velocity in Bragg Cell medium,  
\[ n \] = optical index of refraction.

Coincidently in time, optical beams projecting from both Bragg cells 27 and 29 at identical deflection angles superimpose resulting in a spatial interference pattern along the phase or X axis, as shown in Fig. 2. The two-beam interference pattern equation applies, as given by Equation 2.

\[ E_r^2 = E_1^2 + E_2^2 + 2E_1E_2\cos(\phi_2 - \phi_1) \]  

where:
\[ E_1, E_2 \] = Electric Field strength of the two input signals,  
\[ \phi_1, \phi_2 \] = Electric phase of the two input signals.

Fig. 3 is a graphical plot of optical beam intensity as a function of detector position, size, and pitch. The three photodetector elements D1, D2 and D3 are separated in pitch by a distance corresponding to a span of ninety degrees of the interference pattern period. Note that the detector element (sample) width can vary from near zero to the entire spacing.
pitch without effect upon the resultant derived phase
measurement, except for signal to noise ratio that is related to
captured signal energy. Additionally, the derived phase
measurement is unaffected by signal amplitude variation over the
operating dynamic range.

Fig. 4 represents the interference pattern shape more likely
to be found in practice in which the Bragg Cells 27 and 29 of
Fig. 2 and the optical beam profiles along the phase or X-axis of
Fig. 2 are taken into account. Effects of the resulting
intensity envelope modulation upon the interference pattern
derived phase measurement can be minimized by proper optical
design or apodization correction, as has been shown by applicants
in the apparatus of Fig. 2.

Returning now to Fig. 2, the exemplary detector array 33 is
shown as being comprised of a set of three detectors along the
phase or X-axis and N sets of phase detectors disposed along the
orthogonal frequency or Y-axis. For ease of understanding, each
detector is identified by "D" followed by two digits, with "D"
representing a detector and the following two numbers
respectively representing the frequency row along the Y-axis in
which the detector is located and the relative column position
within that row along the phase or X-axis. For example, D31
represent a detector in the third row along the Y-axis and in the
first column in that row along the X-axis.
The amplitude-detected outputs from each group of three
detectors in a row along each frequency channel number in which a
signal frequency has been detected are applied to an associated
phase extraction processor 35 (Fig. 2A) in phase extraction
processors 37 to determine the phase difference between the two
RF inputs (RF₀ and RF₁) being applied to the Bragg Cells 27 and
29 at a particular channel frequency. To understand how a phase
difference is determined by a phase extraction processor 35
Fig. 2A will now be discussed.

The amplitude outputs from three intensity-sensitive
detectors in a given frequency row along the frequency or Y-axis
are applied to the phase extraction processor 35 to determine the
phase difference Δφ between the RF₀ and RF₁ inputs at the
frequency of the given frequency row. The required mathematical
equations that are utilized by the phase extraction processor 35
for electrical phase measurement extraction are provided as
follows:

\[
D₁ = Eₘ^2 + Eₐ^2 + 2EₘEₐ\sin(ϕₘ - ϕₐ)
\]

\[
D₂ = Eₘ^2 + Eₐ^2 + 2EₘEₐ\cos(ϕₘ - ϕₐ)
\]

\[
D₃ = Eₘ^2 + Eₐ^2 - 2EₘEₐ\sin(ϕₘ - ϕₐ)
\]

where:

\[Eₘ = \text{Electric field strength of measured signal,}\]

\[Eₐ = \text{Electric field strength of reference signal,}\]
$\phi_m = \text{Electric phase of measured signal,}$

$\phi_r = \text{Electric phase of reference signal,}$

and

$D1, D2, D3 = \text{Measured signal energy (or power) from detector D1,}$

$D2, D3 \text{ (Fig. 3).}$

Thus,

$E_m^2 + E_r^2 = D1 + D3,$

$\Delta\phi = \tan^{-1}((D1 - (E_m^2 + E_r^2))/D2 - (E_m^2 + E_r^2))$

This simplifies to:

$\Delta\phi = \tan^{-1}(-D3)/(D2-D1-D3))$

where:

$\Delta\phi = \phi_m - \phi_r.$

The above-discussed required mathematical equations for phase measurement extraction apply generally for all input signal amplitudes, and therefore model the relative phase measurement process independent of signal field strength (or amplitude).

Fig. 5 illustrates a schematic block diagram of the multiple parallel phase measurement apparatus of the invention in a passive direction finding (DF) receiver application. This is a channelized RF interferometer utilizing, for example, four antenna elements 41-44 in a sparsely populated antenna array,
such as a phased array antenna.

RF signals from the antenna elements 41-44 are respectively
downconverted by converters 47-50 to a common intermediate
frequency (IF) appropriate for subsequent processing, with
relative phase maintained in the process. Three CPD modules 53,
55 and 57 are utilized in the system of Fig. 5, with each of the
CPD modules 53, 55 and 57 being similar in structure and
operation to the CPD of Fig. 2. Hence, no further description of
the CPDs is needed.

The CPDs 53, 55 and 57 are required to extract the three
corresponding phase differences on a frequency channelized basis,
as was done for the one frequency channel in Fig. 2. Each CPD
module output provides multiple phase measurements, one for each
frequency bin or channel. In actuality, RF signal environment
activity in conjunction with receiver performance parameters
determine how many output channels will contain valid
measurements.

Data from the three CPD modules are processed on a frequency
channel-by-channel basis by a channelizer processing electronics
(CPE) unit 59 to extract measurement parameters of interest,
typically RF frequency, Angle of Arrival (AOA), and Time of
Arrival. The CPE 59 implements the required parameter extraction
algorithms and formats measurement data into a pulse descriptor
word (PDW) stream for transmission to a signal sorter (SS) 61.
The signal sorter processes blocks of PDWs to resolve individual
RF emitters and correlates measured data with an internal
database of known emitter parametrics to identify the signal
source if possible.

A mathematical explanation of the operation of a typical CPE
can be found in APPENDIX H, entitled "Subroutine for the Maximum
Likelihood Method of Ambiguity Resolution", can be found in NRL
Report 6603, entitled "Ambiguity Resolution in the SPASUR Radio
Interference Direction Finding System", by Frank A. Polkinghorn,
Jr., and Herbert Farnham, dated October 12, 1967 of the Naval
Research Laboratory, Washington, D.C. This NRL Report 6603 is
incorporated by reference into this application.

Fig. 6 shows the experimentally measured phase accuracy of
the system of Fig. 2 to a single RF channel input pair, provided
by a phase modulated RF source having less than 3.0 degrees peak
error.

Fig. 6 just shows an electrical phase error. Along the Y or
vertical axis is the electrical phase error, given a particular
simulated direction of arrival of an RF signal input. The
applied electrical phase difference (X-axis) has been translated
to an equivalent spatial angle of arrival. So a radar signal or a
signal of interest at a particular angle of arrival can be
simulated. Then, by examination it can be determined: the
correctness of the phase that should occur, the $\Delta \phi$ in the above-
discussed equation, and what it should be and how much in error it is in degrees. This shows that phase can be measured very accurately - within a few degrees.

ADVANTAGES AND NEW FEATURES OF THE INVENTION

Phase measurement by spatial sampling is desirable in multi-channel applications because of its simplified implementation and inherently parallel operation. Spatial sampling on a per channel basis, requires measurement of three detector output levels (voltage for instance) followed by application of a simple measurement algorithm to extract relative carrier phase.

Use of three detection elements serves to minimize the required number of sampling elements and maximize overall signal energy utilization. Fewer detection elements per frequency channel result in a higher speed, and a less complex (and hence more compact) implementation of the apparatus.

Spatial intensity modulation along the detector array phase axis affords simultaneous recovery of relative signal amplitude and phase, and removal of the intensity offset during a single sample time.

Incoherent or coherent detection is possible using the Multiple Parallel Spatial Phase Measurement approach. Incoherent or power detection simplifies subsequent signal processing hardware requirements, operating at relatively narrow video
bandwidth. In contrast, typical coherent signal processing requires relatively complex processing hardware per channel to operate at intermediate frequencies (IF), but potentially has a larger dynamic range.

Presently available phase detector devices are single frequency devices designed to operate accurately over a narrow input signal dynamic range. Injection of multiple coincident signals into existing devices requires a separate phase detector-resolver device for each frequency channel.

ALTERNATIVES

The Multiple Parallel Spatial Phase measurement approach is not limited to RF input signals, nor is the modulation of a common optical carrier as in the preferred embodiment a requirement. Input signals may be sound, heat, light, electrical voltage, or any measurable quantity which may be modulated onto the common carrier at multiple frequency offsets. Although an optical carrier was used in the preferred embodiment, the common carrier may also be represented in other forms (ie radio waves) or frequency spectral ranges as well. Thus, for example, RF applications may utilize microwave or millimeterwave bands, or optical applications operating at infrared or ultraviolet wavelengths.
The means to separate the input RF bandwidth into separate operational frequency channels (for instance acoustic-optic Bragg cell channelization in the preferred embodiment of Fig. 2) does not prescribe any particular component or approach as long as input signal phase is preserved in the channelization process.

Modulation of a common carrier by input signal phase at each frequency channel may be accomplished by any modulation means, the acousto-optic Bragg Cell of the preferred embodiment is an especially effective means of simultaneous phase and frequency modulation.

Although the detector array implied a single device containing all elements, this is not a requirement. The detector readout method was not specified and as such may be fully parallel, fully serial, serial-parallel, or queued with respect to some activity detection mechanism for example, which does not alter the disclosed approach.

Three detector elements per frequency channel are considered the minimum necessary for measurement of relative signal phase using the method of spatial phase sampling described herein. The approach is not limited to quantity three elements however, any number of detector elements may be used for reasons of efficiency or otherwise. Also detector elements: need not be located on sequential spatial phase quadrants, need not have "exact" ninety degree spacing, and elements need not have sensing region widths
of ninety degrees; for the approach to function adequately.

The disclosed approach is applicable to both incoherent
(video output) or coherent (IF output) signal processing methods.
Specific applications may dictate which processing method is
preferable.

The physical configuration of the disclosed apparatus is
non-specific, the means to generate a two-signal spatial
interference pattern on the detector at each frequency channel is
non-specific as well.

Therefore, what has been described in a preferred embodiment
of the invention is a multiple, parallel, spatial phase
measurement signal processing apparatus for providing accurate
electrical phase difference measurement of multiple signal inputs
concurrently. In operation, measurement and reference wideband
RF inputs, differing primarily in phase over frequency, are
respectively applied to two RF Channelizer components. Each
Channelizer separates the composite input bandwidth into multiple
time-coincident frequency output channels. Corresponding pairs
of output channels then phase modulate a common independent
carrier which propagates to the detection plane of a
photodetector array forming a spatial interference pattern along
one axis for each frequency channel number. A preferred detector
element scaling relative to the interference pattern affords
efficient phase difference measurement incorporating three
intensity-sensing detector elements at each frequency channel.
Conversion of the resulting amplitudes from the preferred three
detector elements to relative signal phase is accomplished with
an algorithm. Phase measurement of an individual signal input is
accomplished utilizing an efficient spatial sampling scheme.

It should therefore readily be understood that many
modifications and variations of the present invention are
possible within the purview of the claimed invention. It is
therefore to be understood that,

the invention may be practiced otherwise than as
specifically described.
A signal processing apparatus for providing accurate
electrical phase difference measurement of multiple concurrent
signal inputs is disclosed. Phase measurement of an individual
signal input is accomplished utilizing an efficient spatial
sampling scheme. In operation, measurement and reference
wideband RF inputs, differing primarily in phase over frequency,
are respectively applied to two RF Channelizer components. Each
Channelizer separates the composite input bandwidth into multiple
time-coincident frequency output channels. Corresponding pairs
of output channels then phase modulate a common independent
carrier which propagates to the detection plane of a
photodetector array forming a spatial interference pattern along
one axis for each frequency channel number. A preferred detector
element scaling relative to the interference pattern affords
efficient phase difference measurement incorporating three
detector elements at each frequency channel. Conversion of the
preferred three detector element intensity values to relative
signal phase is accomplished with an algorithm.
FIG 3. SPATIAL INTERFERENCE PATTERN AND DETECTOR PITCH
FIG. 4  TYPICAL DETECTOR CHANNEL INTERFERENCE PATTERN.
SYSTEM BLOCK DIAGRAM

RF DOWNCONVERTER

FIG. 5
DF MEASUREMENT PERFORMANCE

Measured Phase Error (Electrical degrees)

Input DF Angle (Spatial degrees)

FIG. 6